

# PROCEEDINGS OF SPIE

## ***Terahertz Physics, Devices, and Systems V: Advance Applications in Industry and Defense***

**A. F. Mehdi Anwar**  
**Nibir K. Dhar**  
**Thomas W. Crowe**  
*Editors*

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# Contents

vii Conference Committee

---

## SESSION 1 KEYNOTE SESSION

---

- 8023 02 **Toward realizing high power semiconductor terahertz laser sources at room temperature** [8023-01]  
M. Razeghi, Northwestern Univ. (United States)

---

## SESSION 2 ADVANCE CONCEPTS IN THZ TECHNOLOGY

---

- 8023 04 **Terahertz light amplification by stimulated emission of radiation from optically pumped graphene (Invited Paper)** [8023-03]  
T. Otsuji, S. A. Boubanga Tombet, Tohoku Univ. (Japan) and JST-CREST (Japan); S. Chan, Univ. of Pennsylvania (United States); A. Satou, Tohoku Univ. (Japan) and JST-CREST (Japan); V. Ryzhii, Univ. of Aizu (Japan) and JST-CREST (Japan)
- 8023 05 **Modeling electron transport coherence in one and two-well terahertz step well quantum cascade structures with diagonal optical transitions** [8023-04]  
W. Freeman, Naval Air Warfare Ctr. (United States)
- 8023 06 **Combining backwards wave oscillator and solid state frequency multipliers to extend spectral coverage of electronic sources to 2.2 THz** [8023-05]  
W. C. Hurlbut, V. G. Kozlov, Microtech Instruments, Inc. (United States)
- 8023 07 **Terahertz detection by field effect transistors security imaging** [8023-06]  
W. Knap, F. Teppe, C. Consejo, B. Chenaud, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (France); J. Torres, Institut d'Electroniques du Sud, CNRS, Univ. Montpellier II (France); P. Solignac, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (France); Z. R. Wasilewski, National Research Council Canada (Canada); M. Zholudev, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (France) and Institute for Physics of Microstructures (Russian Federation); N. Dyakonova, D. Coquillat, P. Buzatu, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (France); A. El Fatimy, Cardiff Univ. (United Kingdom); F. Schuster, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (France) and CEA-LETI, MINATEC (France); H. Videlier, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (France); M. Sakowicz, Lab. Charles Coulomb, CNRS, Univ. Montpellier II (Canada); B. Giffard, CEA-LETI, MINATEC (France); T. Skotnicki, STMicroelectronics (France); F. Palma, NTT New Tera Technology s.r.l. (Italy)
- 8023 09 **Active layer design of THz GaN quantum cascade lasers** [8023-08]  
H. Chou, Univ. of Connecticut (United States); T. Manzur, Naval Undersea Warfare Ctr. (United States); M. Anwar, Univ. of Connecticut (United States)

---

**SESSION 3 THZ IMAGING**

---

- 8023 0A **A real-time terahertz imaging system consisting of terahertz quantum cascade laser and uncooled microbolometer array detector (Invited Paper) [8023-09]**  
I. Hosako, N. Sekine, National Institute of Information and Communications Technology (Japan); N. Oda, M. Sano, S. Kurashina, M. Miyoshi, K. Sonoda, H. Yoneyama, T. Sasaki, NEC Guidance and Electro-Optics Division (Japan)
- 8023 0C **Noise-equivalent power characterization of an uncooled microbolometer-based THz imaging camera [8023-11]**  
M. Bolduc, M. Terroux, B. Tremblay, L. Marchese, E. Savard, M. Doucet, H. Oulachgar, C. Alain, H. Jerominek, A. Bergeron, INO (Canada)
- 8023 0D **Multi-level segmentation of passive millimeter wave images with Gaussian mixture modeling [8023-12]**  
S. Yeom, D.-S. Lee, J.-Y. Son, Daegu Univ. (Korea, Republic of)
- 8023 0E **Active THz imaging and explosive detection with uncooled antenna-coupled microbolometer arrays [8023-13]**  
J. Meilhan, B. Dupont, V. Goudon, G. Lasfargues, J. Lalanne Dera, D. T. Nguyen, J. L. Ouvrier-Buffet, S. Pocas, CEA-LETI, MINATEC (France); T. Maillou, CEA Le Ripault (France); O. Cathabard, S. Barbieri, Lab. Matériaux et phénomènes quantiques, CNRS, Univ. Paris 7 (France); F. Simoens, CEA-LETI, MINATEC (France)
- 8023 0F **Development of an 80 x 64 pixel, broadband, real-time THz imager [8023-14]**  
D. J. Burdette, Traycer Diagnostic Systems, Inc. (United States); J. Alverbro, IRnova AB (Sweden); Z. Zhang, P. Fay, Univ. of Notre Dame (United States); Y. Ni, P. Potet, New Imaging Technologies (France); K. Sertel, G. Trichopoulos, K. Topalli, J. Volakis, The Ohio State Univ. (United States); H. L. Mosbacher, Traycer Diagnostic Systems, Inc. (United States)
- 8023 0G **Broadband sub-millimeter wave amplifier module with 38dB gain and 8.3dB noise figure [8023-15]**  
S. Sarkozy, K. Leong, R. Lai, R. Leakey, W. Yoshida, X. Mei, J. Lee, P.-H. Liu, B. Gorospe, W. R. Deal, Northrop Grumman Aerospace Systems (United States)
- 8023 0H **Sensitive water concentration mapping in thin fresh tissues using tunable THz-wave parametric oscillator [8023-16]**  
Y. Wang, M. Tang, T. Notake, K. Nawata, H. Ito, H. Minamide, RIKEN (Japan)

---

**SESSION 4 THZ GENERATION**

---

- 8023 0I **Frequency-agile terahertz-wave sources and applications to sensitive diagnosis of semiconductor wafers (Invited Paper) [8023-17]**  
H. Minamide, H. Ito, RIKEN (Japan)
- 8023 0J **Optimized THz emission from intrinsic Josephson junctions [8023-18]**  
N. A. Moody, L. N. Boulaevskii, V. Pavlenko, Los Alamos National Lab. (United States)

- 8023 0K **Intracavity terahertz generation from gallium arsenide in a fiber laser pumped type 0 doubly resonant optical parametric oscillator** [8023-19]  
W. C. Hurlbut, V. G. Kozlov, P. Tekavec, Microtech Instruments, Inc. (United States);  
K. Vodopyanov, Stanford Univ. (United States)
- 8023 0L **InP and InGaAs Schottky-type terahertz emitter excited at a wavelength of 1560nm** [8023-20]  
M. Tonouchi, M. Suzuki, K. Serita, I. Kawayama, H. Murakami, Osaka Univ. (Japan)

---

**SESSION 5 THZ DETECTION**

---

- 8023 0M **Terahertz spectroscopy of energetic materials** [8023-21]  
E. M. Witko, T. M. Korter, Syracuse Univ. (United States); J. Wilkinson, W. Ouellette,  
J. Lightstone, Naval Surface Warfare Ctr., Indian Head (United States)
- 8023 0N **Terahertz remote sensing** [8023-22]  
A. Kellarev, D. Sheffer, IARD Sensing Solutions Ltd. (Israel)
- 8023 0O **The method of the spectral dynamics analysis of reflected signal for problem of identification of substance** [8023-23]  
V. A. Trofimov, S. A. Varentsova, Lomonosov Moscow State Univ. (Russian Federation);  
N. Palka, M. Szustakowski, T. Trzcinski, Military Univ. of Technology (Poland)
- 8023 0P **Terahertz imaging with InP high-electron-mobility transistors** [8023-25]  
T. Watanabe, K. Akagawa, Y. Tanimoto, Tohoku Univ. (Japan); D. Coquillat, W. Knap, CNRS,  
Univ. Montpellier 2 (France); T. Otsuji, Tohoku Univ. (Japan)

---

**SESSION 6 THZ SPECTROSCOPY**

---

- 8023 0Q **Laser terahertz emission microscope (Invited Paper)** [8023-26]  
M. Tonouchi, S. Kim, I. Kawayama, H. Murakami, Osaka Univ. (Japan)
- 8023 0R **Plasmon resonance response to millimeter-waves of grating-gated InGaAs/InP HEMT** [8023-27]  
N. Nader Esfahani, C. J. Fredricksen, G. Medhi, R. E. Peale, Univ. of Central Florida (United States); J. W. Cleary, W. R. Buchwald, Air Force Research Lab. (United States); H. Saxena, O. J. Edwards, Zyberwear, Inc. (United States)
- 8023 0U **Computational methods for THz material characterization** [8023-30]  
A. Sokolnikov, Visual Solutions and Applications (United States)

---

**POSTER SESSION**

---

- 8023 0W **Ground state resonance structure calculated by density functional theory for estimating the dielectric response of the high explosive PETN** [8023-32]  
A. Shabaev, George Mason Univ. (United States); S. G. Lambrakos, N. Bernstein, V. L. Jacobs,  
Naval Research Lab. (United States); D. Finkenstadt, U.S. Naval Academy (United States)

- 8023 0X **Investigation of plasmonic resonances in the two-dimensional electron gas of an InGaAs/InP high electron mobility transistor** [8023-33]  
J. W. Cleary, Solid State Scientific Corp. (United States); R. E. Peale, Univ. of Central Florida (United States); H. Saxena, Zyberwear, Inc. (United States); W. R. Buchwald, Air Force Research Lab. (United States)
- 8023 0Y **Plasmonic parametric oscillator via coupling between optically and electrically induced plasmons** [8023-34]  
J. Khouri, C. L. Woods, Air Force Research Lab. (United States); J. J. Donoghue, J. Kierstead, Solid State Scientific Corp. (United States)
- 8023 0Z **Plasmonic modulation using high-frequency current** [8023-35]  
J. Khouri, C. L. Woods, Air Force Research Lab. (United States); J. Donoghue, J. Kierstead, Solid State Scientific Corp. (United States)
- 8023 10 **An investigation of parallel plate waveguide terahertz radiation input coupling** [8023-36]  
A. Higgins, B. Pejcincovic, C. Cowen, F. Kernan, Portland State Univ. (United States)

*Author Index*

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- 1    Keynote Session  
**Tariq Manzur**, Naval Undersea Warfare Center (United States)  
**Nibir K. Dhar**, Defense Advanced Research Projects Agency  
(United States)
- 2    Advance Concepts in THz Technology  
**Gottfried H. Döhler**, Friedrich-Alexander-Universität Erlangen-Nürnberg  
(Germany)  
**A. F. Mehdi Anwar**, University of Connecticut (United States)
- 3    THz Imaging  
**Taiichi Otsuji**, Tohoku University (Japan)  
**Gottfried H. Döhler**, Friedrich-Alexander-Universität Erlangen-Nürnberg  
(Germany)
- 4    THz Generation  
**A. F. Mehdi Anwar**, University of Connecticut (United States)  
**Nibir K. Dhar**, Defense Advanced Research Projects Agency  
(United States)
- 5    THz Detection  
**Tariq Manzur**, Naval Undersea Warfare Center (United States)  
**Taiichi Otsuji**, Tohoku University (Japan)
- 6    THz Spectroscopy  
**A. F. Mehdi Anwar**, University of Connecticut (United States)  
**Tariq Manzur**, Naval Undersea Warfare Center (United States)